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Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	451
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	83
Number of Gates	2500
Voltage - Supply	4.5V ~ 5.5V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	100-BQFP
Supplier Device Package	100-PQFP (20x14)
Purchase URL	https://www.e-xfl.com/product-detail/microsemi/a1225a-pq100c

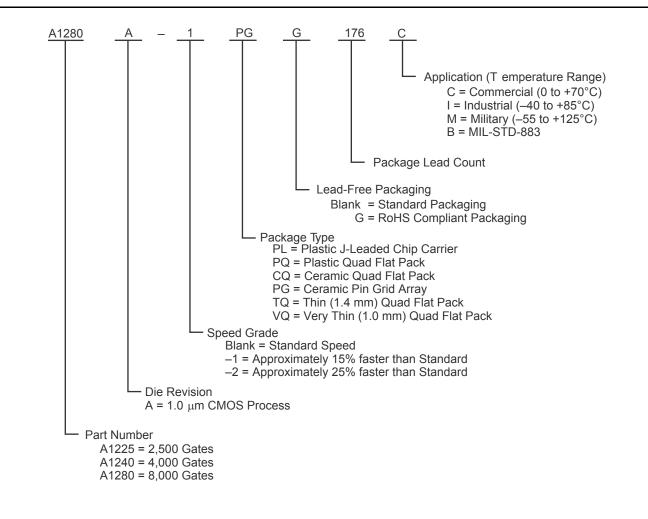
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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Microsemi.

ACT 2 Family FPGAs

Ordering Information



2 – Detailed Specifications

Operating Conditions

Table 2-1 • Absolute Maximum Ratings¹

Symbol	Parameter	Limits	Units
VCC	DC supply voltage	–0.5 to +7.0	V
VI	Input voltage	-0.5 to VCC + 0.5	V
VO	Output voltage	-0.5 to VCC + 0.5	V
IIO	I/O source sink current ²	±20	mA
T _{STG}	Storage temperature	-65 to +150	°C

Notes:

1. Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. Exposure to absolute maximum rated conditions for extended periods may affect device reliability. Device should not be operated outside the recommended operating conditions.

2. Device inputs are normally high impedance and draw extremely low current. However, when input voltage is greater than VCC + 0.5 V for less than GND –0.5 V, the internal protection diodes will be forward biased and can draw excessive current.

Table 2-2 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature range*	0 to +70	-40 to +85	–55 to +125	°C
Power supply tolerance	±5	±10	±10	%VCC

Note: *Ambient temperature (T_A) is used for commercial and industrial; case temperature (T_C) is used for military.



Detailed Specifications

Table 2-3 • Electrical Specifications

		Con	nmercial	Industrial		Military		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Units
VOH ¹	$(IOH = -10 \text{ mA})^2$	2.4	-	_	_	_	-	V
	(IOH = –6 mA)	3.84	-	_	_	_	-	V
	(IOH = -4 mA)	-	-	3.7	-	3.7	-	V
VOL ¹	(IOL = 10 mA) ²	-	0.5	_	-	_	-	V
	(IOL = 6 mA)	-	0.33	_	0.40	_	0.40	V
VIL		-0.3	0.8	-0.3	0.8	-0.3	0.8	V
VIH		2.0	VCC + 0.3	2.0	VCC + 0.3	2.0	VCC + 0.3	V
Input Tran	sition Time t _R , t _F ²	-	500	_	500	-	500	ns
C _{IO} I/O caj	pacitance ^{2,3}	-	10	_	10	-	10	pF
Standby C	urrent, ICC ⁴ (typical = 1 mA)	-	2	_	10	_	20	mA
Leakage Current ⁵		-10	+10	-10	+10	-10	+10	μA
ICC(D)	Dynamic VCC supply curren	t. See the	Power Dissip	ation see	ction.		1	1

Notes:

1. Only one output tested at a time. VCC = minimum.

2. Not tested, for information only.

3. Includes worst-case PG176 package capacitance. VOUT = 0 V, f = 1 MHz

4. All outputs unloaded. All inputs = VCC or GND, typical ICC = 1 mA. ICC limit includes IPP and ISV during normal operations.

5. VOUT, VIN = VCC or GND.

Package Thermal Characteristics

The device junction to case thermal characteristic is θ jc, and the junction to ambient air characteristic is θ ja. The thermal characteristics for θ ja are shown with two different air flow rates.

Maximum junction temperature is 150°C.

A sample calculation of the absolute maximum power dissipation allowed for a PQ160 package at commercial temperature and still air is as follows:

$$\frac{\text{Max. junction temp. (°C)} - \text{Max. ambient temp. (°C)}}{\theta_{ja} °C/W} = \frac{150°C - 70°C}{33°C/W} = 2.4 \text{ W}$$

EQ 1

Package Type∗	Pin Count	θ _{jc}	^θ ja Still Air	θ _{ja} 300 ft./min.	Units
Ceramic Pin Grid Array	100	5	35	17	°C/W
	132	5	30	15	°C/W
	176	8	23	12	°C/W
Ceramic Quad Flatpack	172	8	25	15	°C/W
Plastic Quad Flatpack ¹	100	13	48	40	°C/W
	144	15	40	32	°C/W
	160	15	38	30	°C/W
Plastic Leaded Chip Carrier	84	12	37	28	°C/W
Very Thin Quad Flatpack	100	12	43	35	°C/W
Thin Quad Flatpack	176	15	32	25	°C/W

Table 2-4 • Package Thermal Characteristics

Notes: (Maximum Power in Still Air)

1. Maximum power dissipation values for PQFP packages are 1.9 W (PQ100), 2.3 W (PQ144), and 2.4 W (PQ160).

2. Maximum power dissipation for PLCC packages is 2.7 W.

3. Maximum power dissipation for VQFP packages is 2.3 W.

4. Maximum power dissipation for TQFP packages is 3.1 W.

Power Dissipation

P = [ICC standby + ICCactive] * VCC + IOL * VOL * N + IOH* (VCC – VOH) * M

EQ 2

where:

ICC standby is the current flowing when no inputs or outputs are changing

ICCactive is the current flowing due to CMOS switching.

IOL and IOH are TTL sink/source currents.

VOL and VOH are TTL level output voltages.

N is the number of outputs driving TTL loads to VOL.

M is the number of outputs driving TTL loads to VOH.

An accurate determination of N and M is problematical because their values depend on the family type, design details, and on the system I/O. The power can be divided into two components: static and active.



Detailed Specifications

Parameter Measurement

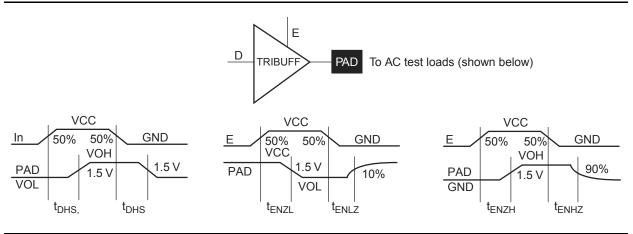


Figure 2-2 • Output Buffer Delays

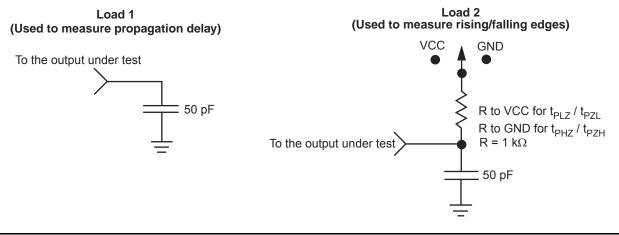


Figure 2-3 • AC Test Loads

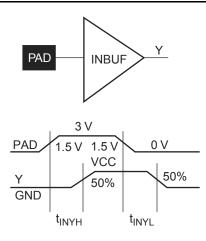


Figure 2-4 • Input Buffer Delays

A1280A Timing Characteristics (continued)

Table 2-19 • A1280A Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C

I/O Module Input Propagation Delays Parameter/Description		-2 S	peed	–1 S	peed	Std. Speed		Units	
		Min.	Max.	Min.	Max.	Min.	Max.	1	
t _{INYH}	Pad to Y High			2.9		3.3		3.8	ns
t _{INYL}	Pad to Y Low			2.7		3.0		3.5	ns
t _{INGH}	G to Y High			5.0		5.7		6.6	ns
t _{INGL}	G to Y Low			4.8		5.4		6.3	ns
Input M	odule Predicted Input Routing Del	ays [*]	-				-	-	
t _{IRD1}	FO = 1 Routing Delay			4.6		5.1		6.0	ns
t _{IRD2}	FO = 2 Routing Delay			5.2		5.9		6.9	ns
t _{IRD3}	FO = 3 Routing Delay			5.6		6.3		7.4	ns
t _{IRD4}	FO = 4 Routing Delay			6.5		7.3		8.6	ns
t _{IRD8}	FO = 8 Routing Delay			9.4		10.5		12.4	ns
Global (Clock Network		-				-	-	
t _{скн}	Input Low to High	FO = 32		10.2		11.0		12.8	ns
		FO = 256		13.1		14.6		17.2	1
t _{CKL}	Input High to Low	FO = 32		10.2		11.0		12.8	ns
		FO = 256		13.3		14.9		17.5	
t _{PWH}	Minimum Pulse Width High	FO = 32	5.0		5.5		6.6		ns
		FO = 256	5.8		6.4		7.6		
t _{PWL}	Minimum Pulse Width Low	FO = 32	5.0		5.5		6.6		ns
		FO = 256	5.8		6.4		7.6		
t _{CKSW}	Maximum Skew	FO = 32		0.5		0.5		0.5	ns
		FO = 256		2.5		2.5		2.5	
t _{SUEXT}	Input Latch External Setup	FO = 32	0.0		0.0		0.0		ns
		FO = 256	0.0		0.0		0.0		
t _{HEXT}	Input Latch External Hold	FO = 32	7.0		7.0		7.0		ns
		FO = 256	11.2		11.2		11.2		
t _P	Minimum Period	FO = 32	9.6		11.2		13.3		ns
		FO = 256	10.6		12.6		15.3]
f _{MAX}	Maximum Frequency	FO = 32		105.0		90.0		75.0	ns
		FO = 256		95.0		80.0		65.0	1

Note: *These parameters should be used for estimating device performance. Optimization techniques may further reduce delays by 0 to 4 ns. Routing delays are for typical designs across worst-case operating conditions. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.

A1280A Timing Characteristics (continued)

Pin Descriptions

CLKA Clock A (Input)

TTL Clock input for clock distribution networks. The Clock input is buffered prior to clocking the logic modules. This pin can also be used as an I/O.

CLKB Clock B (Input)

TTL Clock input for clock distribution networks. The Clock input is buffered prior to clocking the logic modules. This pin can also be used as an I/O.

DCLK Diagnostic Clock (Input)

TTL Clock input for diagnostic probe and device programming. DCLK is active when the MODE pin is High. This pin functions as an I/O when the MODE pin is Low.

GND Ground

Low supply voltage.

I/O Input/Output (Input, Output)

The I/O pin functions as an input, output, three-state, or bidirectional buffer. Input and output levels are compatible with standard TTL and CMOS specifications. Unused I/O pins are automatically driven Low by the ALS software.

MODE Mode (Input)

The MODE pin controls the use of multifunction pins (DCLK, PRA, PRB, SDI). When the MODE pin is High, the special functions are active. When the MODE pin is Low, the pins function as I/Os. To provide Actionprobe capability, the MODE pin should be terminated to GND through a 10K resistor so that the MODE pin can be pulled High when required.

NC No Connection

This pin is not connected to circuitry within the device.

PRA Probe A (Output)

The Probe A pin is used to output data from any user-defined design node within the device. This independent diagnostic pin can be used in conjunction with the Probe B pin to allow real-time diagnostic output of any signal path within the device. The Probe A pin can be used as a user-defined I/O when debugging has been completed. The pin's probe capabilities can be permanently disabled to protect programmed design confidentiality. PRA is active when the MODE pin is High. This pin functions as an I/O when the MODE pin is Low.

PRB Probe B (Output)

The Probe B pin is used to output data from any user-defined design node within the device. This independent diagnostic pin can be used in conjunction with the Probe A pin to allow real-time diagnostic output of any signal path within the device. The Probe B pin can be used as a user-defined I/O when debugging has been completed. The pin's probe capabilities can be permanently disabled to protect programmed design confidentiality. PRB is active when the MODE pin is High. This pin functions as an I/O when the MODE pin is Low.

SDI Serial Data Input (Input)

Serial data input for diagnostic probe and device programming. SDI is active when the MODE pin is High. This pin functions as an I/O when the MODE pin is Low.

SDO Serial Data Output (Output)

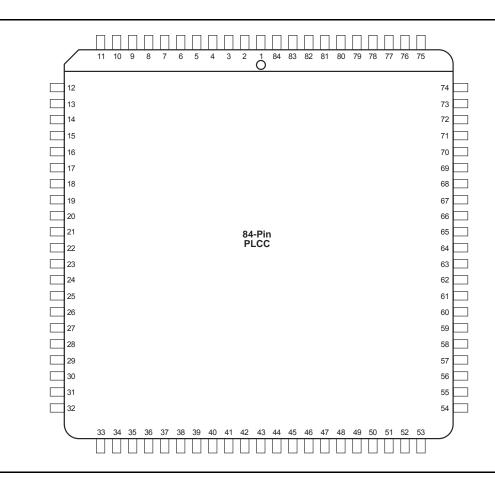
Serial data output for diagnostic probe. SDO is active when the MODE pin is High. This pin functions as an I/O when the MODE pin is Low.

VCC 5.0 V Supply Voltage

High supply voltage.

3 – Package Pin Assignments

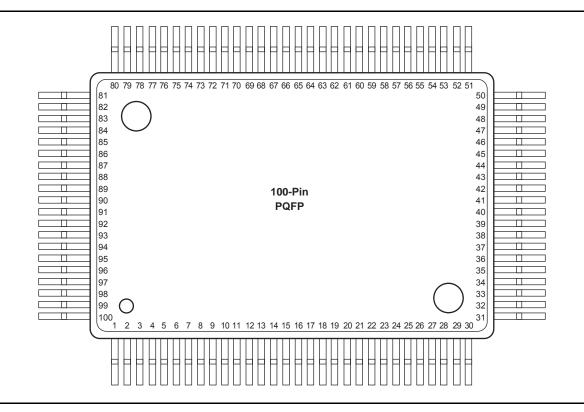
PL84



Note

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PQ100



Note

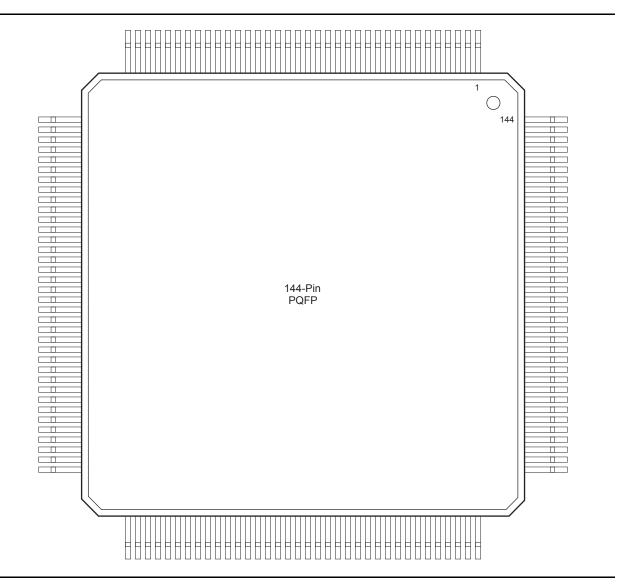
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Package Pin Assignments

	PQ100		PQ100
Pin Number	A1225A Function	Pin Number	A1225A Function
2	DCLK, I/O	65	VCC
4	MODE	66	VCC
9	GND	67	VCC
16	VCC	72	GND
17	VCC	79	SDI, I/O
22	GND	84	GND
34	GND	87	PRA, I/O
40	VCC	89	CLKA, I/O
46	GND	90	VCC
52	SDO	92	CLKB, I/O
57	GND	94	PRB, I/O
64	GND	96	GND

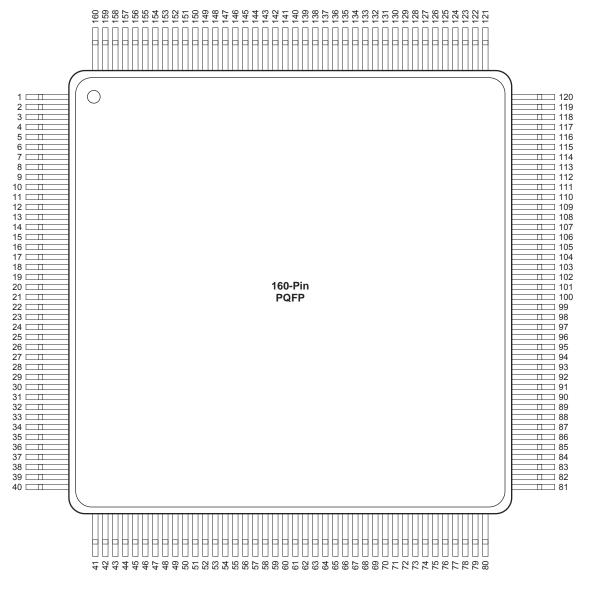
- 1. All unlisted pin numbers are user I/Os.
- 2. MODE pin should be terminated to GND through a 10K resistor to enable Actionprobe usage; otherwise it can be terminated directly to GND.



Note

For Package Manufacturing and Environmental information, visit the Resource Center at http://www.microsemi.com/soc/products/solutions/package/docs.aspx

Microsemi ACT 2 Family FPGAs



Note: This is the top view of the package

Note

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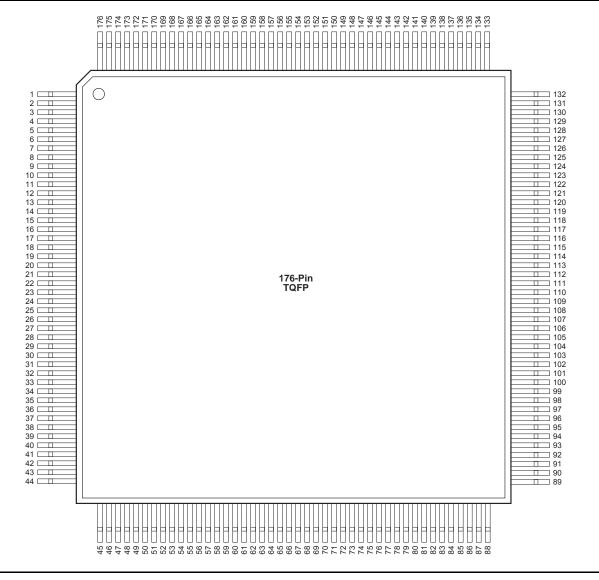


Package Pin Assignments

	VQ100		VQ100
Pin Number	A1225A Function	Pin Number	A1225A Function
2	MODE	64	VCC
7	GND	65	VCC
14	VCC	70	GND
15	VCC	77	SDI, I/O
20	GND	82	GND
32	GND	85	PRA, I/O
38	VCC	87	CLKA, I/O
44	GND	88	VCC
50	SDO	90	CLKB, I/O
55	GND	92	PRB, I/O
62	GND	94	GND
63	VCC	100	DCLK, I/O

- 1. All unlisted pin numbers are user I/Os.
- 2. MODE pin should be terminated to GND through a 10K resistor to enable Actionprobe usage; otherwise it can be terminated directly to GND.





Note

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PG100		Р	G100
Pin Number	A1225A Function	Pin Number	A1225A Function
A4	PRB, I/O	E11	VCC
A7	PRA, I/O	F3	VCC
B6	VCC	F9	VCC
C2	MODE	F10	VCC
C3	DCLK, I/O	F11	GND
C5	GND	G1	VCC
C6	CLKA, I/O	G3	GND
C7	GND	G9	GND
C8	SDI, I/O	J5	GND
D6	CLKB, I/O	J7	GND
D10	GND	J9	SDO
E3	GND	K6	VCC

- 1. All unlisted pin numbers are user I/Os.
- 2. MODE pin should be terminated to GND through a 10K resistor to enable Actionprobe usage; otherwise it can be terminated directly to GND.

PG176			PG176	
Pin Number	A1280A Function	Pin Number	A1280A Function	
A9	CLKA, I/O	H3	VCC	
B3	DCLK, I/O	H4	GND	
B8	CLKB, I/O	H12	GND	
B14	SDI, I/O	H13	VCC	
C3	MODE	H14	VCC	
C8	GND	J4	VCC	
C9	PRA, I/O	J12	GND	
D4	GND	J13	GND	
D5	VCC	J14	VCC	
D6	GND	K4	GND	
D7	PRB, I/O	K12	GND	
D8	VCC	L4	GND	
D10	GND	M4	GND	
D11	VCC	M5	VCC	
D12	GND	M6	GND	
E4	GND	M8	GND	
E12	GND	M10	GND	
F4	VCC	M11	VCC	
F12	GND	M12	GND	
G4	GND	N8	VCC	
G12	VCC	P13	SDO	
H2	VCC			

- 1. All unlisted pin numbers are user I/Os.
- 2. MODE pin should be terminated to GND through a 10K resistor to enable Actionprobe usage; otherwise it can be terminated directly to GND.



Datasheet Information

Datasheet Categories

Categories

In order to provide the latest information to designers, some datasheet parameters are published before data has been fully characterized from silicon devices. The data provided for a given device is designated as either "Product Brief," "Advance," "Preliminary," or "Production." The definitions of these categories are as follows:

Product Brief

The product brief is a summarized version of a datasheet (advance or production) and contains general product information. This document gives an overview of specific device and family information.

Advance

This version contains initial estimated information based on simulation, other products, devices, or speed grades. This information can be used as estimates, but not for production. This label only applies to the DC and Switching Characteristics chapter of the datasheet and will only be used when the data has not been fully characterized.

Preliminary

The datasheet contains information based on simulation and/or initial characterization. The information is believed to be correct, but changes are possible.

Production

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